

Notice of References Cited

Application/Control No.

09/893,676

Applicant(s)/Patent Under
Reexamination
SON ET AL.

Examiner

Jennifer T Nguyen

Art Unit

2674

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,552,704	04-2003	Zavracky et al.	345/88
	B	US-5,666,133	09-1997	Matsuo et al.	345/100
	C	US-			
	D	US-			
	E	US-			
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	K	US-			
	L	US-			
	M	US-			

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Hasegawa et al. Pub. No. US 2001/0011979
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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